

Notice of References Cited	Application/Control No. 10/020,825	Applicant(s)/Patent Under Reexamination CRAIG ET AL.	
	Examiner Hien Tran	Art Unit 1764	Page 1 of 1

U.S. PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-4,182,120	01-1980	Niebylski, Leonard M.	422/176
	C	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS						
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NON-PATENT DOCUMENTS		
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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